#### TC5093AP 8 BIT ANALOG TO DIGITAL CONVERTER

#### GENERAL DESCRIPTION

The TC5093AP is a monolithic CMOS 8 bit successive approximation A/D converter with 8 channel multiplex inputs. After an analog input channel is selected with channel select input (CHO  $\sim$ 2) and channel latch input (CHL), when STC is set high EOC goes low at the leading edge of STC and the conversion starts.

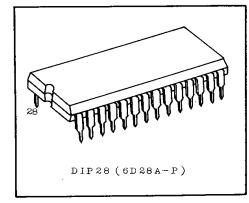
After the conversion is completed, EOC returns high and the new data replace the previous data at DBO  $\sim$  DB7.

The TC5093AP has features of high speed, high accuracy and very low power consumption which make the device well suited to a broad application field such as process and machine control and automotive equipment.

#### **FEATURES**

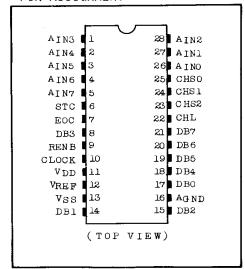
- High accuracy  $\pm \frac{1}{2}$  LSB TYP
- High speed conversion .... 100  $\mu sec$  TYP @f<sub>cp</sub>=640 kHz
- Single power supply ...... 5V ± 10%
- Low power consumption ..... 9mW MAX  $@T_a=25^{\circ}C$
- · 8 channel analog multiplex input
- · Easy interface to all microprocessors
- · Zero or full scale adjustment free
- Latched 3-state output

ABSOLUTE MAXIMUM RATINGS

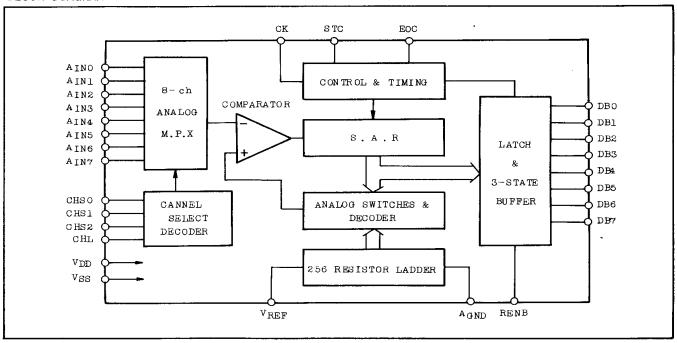


PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	$v_{\mathrm{DD}}$	$V_{SS}-0.5 \sim V_{SS} + 7$	V
DC Input Voltage	VIN	$v_{SS}$ -0.5 $\sim v_{DD}$ +0.5	V
DC Output Voltage	VOUT	$v_{SS}-0.5 \sim v_{DD} + 0.5$	V
Reference Volage	V <sub>REF</sub>	$v_{SS}-0.5 \sim v_{DD} + 0.5$	V
Analog Ground Voltage	AGND	$v_{SS}$ -0.5 $\sim v_{DD}$ +0.5	V
DC Input Current	IIN	±10	mA
Power Dissipation	PD	300	mW
Storage Temperature	TSTG	-65 ∿150 .	°C
Lead Temperature 10 sec.	TL	300	°C

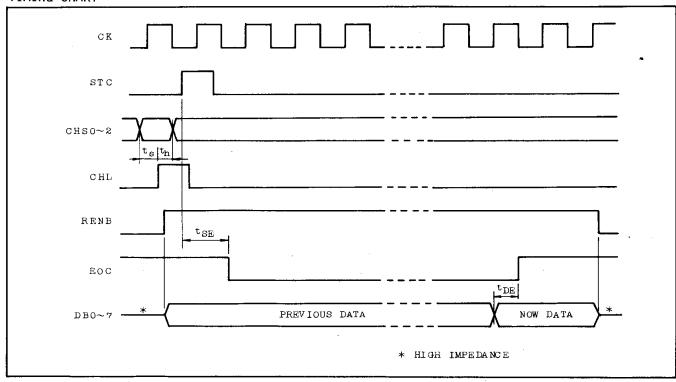
#### PIN ASSIGNMENT



### **BLOCK DIAGRAM**



# TIMING CHART



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# PIN & FUNCTION

PIN NO.	SYMBOL	PIN NAME & FUNCTION	PIN NO.	SYMBOL	PIN NAME & FUNCTION					
1	A <sub>IN3</sub>	[ANALOG INPUT]	15	DB2	3-STATE PARALLEL DATA OUTPUT					
3	A <sub>IN4</sub>	The analog input voltage applied to the selected channel is converted. Full range of input signal is to be from A <sub>GND</sub> to V <sub>REF</sub> .		$A_{ m GND}$	[ANALOG GROUND] $A_{ m GND}$ defines the zero level of $A_{ m IN}$ .					
4	A <sub>IN6</sub>			DB0	3-STATE PARALLEL DATA OUTPUT					
5	A <sub>IN7</sub>		18	DB4	DBO : LSB					
		[START CONVERSION]	19	DB5	DB7 : MSB					
6	STC	Conversion starts at the falling edge of STC.	20	DB6						
		[END OF CONVERSION]	21	DB7						
7	EOC	And when the conversion is completed EOC returns to high level.		CHL	[CHANNEL LATCH INPUT] The channel select signals CHSO ~2 are latched at the rising edge of CHL.					
8	DB3									
9	RENB	[READ ENABLE] Output enable signal	23	CHS2	[CHANNEL SELECT INPUT] One of $A_{\rm INO} \sim A_{\rm IN7}$ is selected according to the status of CHO $\sim$ CH2.					
		"H" = DB0 $\sim$ 7 enable "L" = DB0 $\sim$ 7 high impedance			CHS2 CHS1 CHS0 ON CHANNEL					
10	CLOCK	[CLOCK INPUT] Basic system clock	24	CHS2	L L L AINO L H L AIN2					
11	$v_{\mathrm{DD}}$	[SYSTEM POWER SUPPLY] VDD=5V ± 10%	25	CHS0	L H H AINS H L L AIN4 H L H AIN5					
12	V <sub>REF</sub>	[REFERENCE VOLTAGE] $V_{REF}$ defines the full scale of $A_{IN}$ .		CIISO	H H L AIN6 H H H AIN7					
13	VSS	[SYSTEM GROUND] VSS=0V	26	A <sub>INO</sub>	[ANALOG INPUT]					
		3-STATE PARALLEL	27	A <sub>IN1</sub>						
14	DB1	DATA OUTPUT	28	A <sub>IN2</sub>						

# RECOMMENDED OPERATING CONDITIONS ( $v_{SS}$ =0v)

PARAMETER	PARAMETER SYMBOL CONDITI		MIN.	TYP.	MAX.	UNIT
Supply Voltage	$v_{\mathrm{DD}}$		4.5	5.0	5.5	V
Input Voltage	VIN		0	-	$v_{\mathrm{DD}}$	v
Reference Voltage	$v_{REF}$	V <sub>DD</sub> =5V, AGND=0V	3.5	$v_{\mathrm{DD}}$	$v_{DD}$	v
Analog Ground Voltage	AGND	V <sub>DD</sub> =5V, V <sub>REF</sub> =5V	0.0	0.0	3.0	V
Voltage Between VREF and AGND		V <sub>DD</sub> =5V ± 10%	2.0	$v_{\mathrm{DD}}$	$v_{ m DD}$	V
Clock Frequency	f <sub>cp</sub>	V <sub>DD</sub> =5V ± 10% Duty Cycle=50%	10	640	1280	kHz
Operating Temperature	Topr		-40	-	+85	°C_

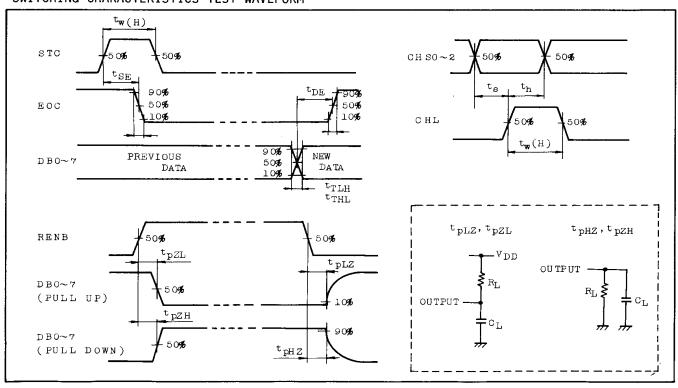
# DC ELECTRICAL CHARACTERISTICS $(v_{SS}=0v)$

GURDOL MEGIT CONDUCTION		-40°C		25°C			85°C		UNIT		
PARAMETER	SYMBOL	TEST CONDITION	$v_{DD}$	MIN.	MAX.	MIN.	TYP.	MAX.	MIN.	MAX.	
High Level Output Voltage	v <sub>OH</sub>	I <sub>OUT</sub>  <1 <sub>µ</sub> A V <sub>IN</sub> =V <sub>SS</sub> ,V <sub>DD</sub>	5.0	4.95	_	4.95	5.00	-	4.95	-	V
Low Level Output Voltage	v <sub>OL</sub>	$\begin{array}{c} \mid \textbf{I}_{OUT} \mid < \textbf{1}_{\mu} \textbf{A} \\ \textbf{V}_{IN} = \textbf{V}_{SS}, \textbf{V}_{DD} \end{array}$	5.0	-	0.05	-	0.00	0.05	-	0.05	V
High Level Output Current	ІОН	$v_{OH}^{=4.6V}$ $v_{IN}^{=4.6V}$	5.0	-1.2	-	-	_	-	-0.7	-	mA
Low Level Output Current	I <sub>OL</sub>	$v_{OL}$ =0.4 $v_{IN}$ = $v_{SS}$ , $v_{DD}$	5.0	2.4	-	2.0	-	-	1.6	-	mA
High Level Input Voltage	VIH	I <sub>OUT</sub>  <1 <sub>µ</sub> A V <sub>OUT</sub> =0.5V, 4.5V	5.0	3.5	-	3.5	-	-	3.5	-	V
Low Level Input Voltage	$v_{IL}$	I <sub>OUT</sub>  <1μΑ V <sub>OUT</sub> =0.5V, 4.5V	5.0	_	1.5	-		1.5	_	1.5	V
3-State Output Disable Current	I <sup>DT</sup>	V <sub>OH</sub> =5.5V or V <sub>OL</sub> =0.0V	5.5	_	±0.5	_	-	±0.5	_	±1	μА
Digital Input Current	IIH	V <sub>IH</sub> =5.5V or V <sub>IL</sub> =0.0V	5.5	_	±0.3	-	-	±0.3	-	±1	μA
On Channel Input Current	ION	$V_{IH}=5.5V$ or $V_{IL}=0.0V$ $f_{cp}=kHz$	5.5	-	±2	_	_	±2	_	±5,	μA
OFF Channel Input Current	I <sub>OFF</sub>	V <sub>IH</sub> =5.5V or V <sub>IL</sub> =0.0V	5.5	_	±0.2	_	_	±0.2	_	±1	μА
Operating Current	ı <sub>DD</sub>	f <sub>cp</sub> =1 MHz	5.0	_	2.0	_	-	1.8	-	2.0	mA
Reference Resistance	RREF		_	4.0	1.7	4.3	7.5	17	4.3	19	kΩ

SWITCHING CHARACTERISTICS ( $v_{DD}$ =5.0v,  $T_a$ =25 $^{\circ}$ C)

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Output Transition Time	t <sub>TLH</sub> t <sub>THL</sub>	C <sub>L</sub> =50 <sub>p</sub> F	-	50	100	
Propagation Delay Time (STC - EOC)	t <sub>SE</sub>	C <sub>L</sub> =50 <sub>p</sub> F	10	1/2 CLOCK + 200	1/2 CLOCK + 600	
Data-EOC Time	tDE	CL=50pF	1 CLOCK -300	1 CLOCK -70	1 CLOCK	
3-State Output Enable Time	tpZH tpZL	C <sub>L</sub> =50pF	-	85	200	
3-State Output	tpHZ	R <sub>L</sub> =1k		85	200	nS
Disable Time	tpLZ		_	65	200	
Minimum Pulse Width (STC. CHL)	t <sub>w</sub> (H)	C <sub>L</sub> =50pF	-	40	100	
Minimum Set-up Time (CHSO ~2)	ts	C <sub>L</sub> =50pF	-	2	50	
Minimum Hold Time (CHSO ∿2)	<sup>t</sup> h	C <sub>L</sub> =50pF	-	0	50	
Input Capacitance	C <sub>IN1</sub>	Digital Input	_	5	_	
Input Capacitance	C <sub>IN2</sub>	Analog In(ON)	_		_	] _ [
Input Capacitance	C <sub>IN3</sub>	Analog In(OFF)	_		_	pF
Output Capacitance	COUT	3-State Out	_	10	_	] ]

### SWITCHING CHARACTERISTICS TEST WAVEFORM



# SYSTEM CHARACTERISTICS $(T_a=25$ °C)

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Zero Point Error	EZR	VDD=5.0V	_	$\pm \frac{1}{4}$	± 1	
Full Scale Error	E <sub>FS</sub>	V <sub>REF</sub> =5.000V	-	$\pm \frac{1}{2}$	± 1	LSB
Nonlinearity Error	E <sub>LI</sub>	t <sub>Cp</sub> =1 MHz	-	$\pm \frac{1}{2}$	± 1	
Conversion Time		f <sub>cp</sub> =640 kHz	_	100		μs
	TC	f <sub>cp</sub> =1280 kHz		50		